

# Feature Selection Based on Improved Particle Swarm Optimization in Software Defect Prediction

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## ABSTRACT

Software testing is an important stage that consumes time, budget, and effort. Thus, software defect prediction helps to identify the defective module, improve the testing process and the overall quality of the software. Many approaches have been conducted by researchers to improve the accuracy of software defect prediction models. Feature selection is a worthy preprocessing technique to enhance applications that uses huge amounts of features. Swarm intelligence algorithms have shown promising performance in improving the feature selection problem and reducing the running time. In this paper, we proposed a software defect prediction model that integrates a sticky binary particle swarm algorithm as feature selection with different classifiers. Also, we compare the performance of the used algorithm with binary particle swarm optimization and without feature selection. This approach is used for the first time to predict software defect modules, and it provides a promising result where the highest accuracy was obtained from the k-nearest neighbor classifier with the accuracy of 87% using sticky binary particle swarm optimization, 85% using binary particle swarm optimization, and 82% without feature selection.

**Keywords:** Software defect prediction, Feature selection, Binary particle swarm optimization, swarm intelligence.

## 1 Introduction

Software Defect Prediction (SDP) is one of the important processes in the software development lifecycle (SDLC) [1]. SDP is the process of identifying and controlling the percentage of defective program units in the software [2] [3]. Defect prediction will improve the testing process and the overall quality of the software [3]. In addition, it will decrease the time, cost, the effort required to rework on the defective units and deliver a more consistent and trusted software [2]. The SDP field started in the 1970s, and now the field has hundreds of related SDP models [4]. In recent studies, SDP models were built using different Machine learning algorithms [5]. The accuracy of SDP models is highly affected by the quality of defect datasets used to build SDP models [6]. The defect dataset features or attributes are growing vastly as software systems are increasing; accordingly, these datasets may contain irrelevant and redundant features that affect the accuracy of classifiers [7] [6]. Feature selection (FS) is used to achieve the best classification performance by selecting the most informative feature subset from the dataset [8]. However, FS is an NP-Hard problem because the number of search spaces increases exponentially when the number of features is increased [7] [9]. Thus, metaheuristic search algorithms are used to find the optimal subset of features within less time [10]. It is random-based method that generates random solutions and can reach a near-optimal solution [9]. Swarm Intelligence (SI) algorithms are one of the metaheuristic algorithms that are inspired by the behaviors of the creatures such as bees, birds, and fishes [9]. SI algorithms involve two main processes, which are exploration and exploitation. Exploration means examining more global regions and finding the diverse solution. In contrast, the exploitation is searching locally to enhance the quality of the solution [9]. Over exploration or over exploitation can lead to losses the optimal solution or premature convergence and suck in local minima [9]. Thus, achieving balance between exploration and exploitation is important for the optimization process. Particle swarm optimization (PSO) is one of the SI algorithms that are used to solve continuous problems [11]. PSO has been extended to Binary PSO (BPSO) in order to solve discrete problems [12]. This paper introduces SDP model that uses improved FS by combining a sticky binary particle swarm algorithm with classification. In addition to using three classifiers which are Naive Bayes

Classifier (NB), K-Nearest Neighbor Classifier (KNN), and Support Vector Machines (SVM) and compare them. Following are the remaining sections of this paper: Section 2 provides a background on the main related concepts to the SDP, FS, classification algorithms and PSO. Section 3 covers all the related work to this study. Section 4 details the methods utilized to implement the SDP model. Section 5 presents the experimental design, section 6 presents the results and relevant discussion. Finally, Section 7 concludes the work.

## **2 Background**

This section handles a background on the main related concepts to this study. First, the section provides an overview of the SDP process. Then, we give a brief description of the FS process and its approaches. In addition, we provide an overview of the used classifiers. Finally, an explanation of the PSO and BPSO.

### **2.1 Software Defect Prediction (SDP)**

The software is exposed to defect during SDLC stages; defects could be arise from the ambiguity of the requirements due to the miscommunication in the requirements elicitation stage, lack of experience in the domain, involving developers with poor technical and programming skills, and so forth [3]. Delivering a software with a defect will cause huge losses[13]. Customers satisfaction is an important issue for any product; therefore, to deliver a high-quality software, the software has to be achieve customer requirements, and developed within the available budget and time [14]. SDP is important before testing operations take place [3]. Software Quality Assurance (SQA) task consumes (30% - 90%) of the budget of the software project [15]. Therefore, Identifying defective modules and managing the defects in the software will improve the testing process, where it focuses on modules that are more expected to work incorrectly [16]. There are three different categories of SDP, prediction the number of defects, the severity of defects and the most frequently used is the prediction of whether the software unit is defective or not [3], where the SDP is used as a binary classification problem that has two classes which are defect and non-defect [17]. Also, it could be used as multi-class classification where the classes are the number of the defect.

### **2.2 Feature Selection (FS)**

Feature selection method is used to select a subset of the space of features in order to remove the irrelevant features, and to simplify data mining procedures when dealing with large datasets by removing unnecessary and/or duplicate features [6]. Accordingly, FS method enhances the prediction process and the performance of the classifiers [7]. With the advent of improved data collecting techniques, the FS step has become critical and required for improving the mining process' performance. The most difficult aspect of the FS process is determining the ideal feature combination [18]. For datasets with a small number of features, the full (exhaustive) search, which tests all potential combinations before selecting the best one, or the exact search methods can be used. When working with high-dimensional datasets, when the search space is exponentially extended, these search algorithms become impractical and time-consuming. To put it another way, the search space for a dataset with  $N$  features consists of  $(2^N - 1)$  feature subsets [19]. As a result, metaheuristics algorithms are the best alternative to the search techniques stated above.

There are two main approaches to feature subset selection used in machine learning: filter and wrapper. The filter-based approach (FFS) selects subsets of features based on the characteristics of the dataset and exclusively independent of the chosen predictor [6][20]. Accordingly, The advantage of FFS is that it has a low computational cost and high scalability [6]. Wrapper-based approaches (WFS) utilize a prediction model to assess relative usefulness of subsets of features [6][20]. In contrast to the FFS, that asses each feature independently, considering the interdependencies of each feature with the prediction model makes the WFS more WFS accurate [6][21]. Accordingly, this methods are computationally expensive but are more superior to FFS based on existing studies [21][22][23]. In addition to these two main approaches, there is a hybrid

technique of both filter and wrapper, which is the embedded method. In the embedded method, filter method is applied to the initial features to find the best features using some independent criteria; then wrapper method is applied to the same subset and evaluated using the learning algorithm, to find the accuracy [24][2]. Embedded method is less computationally expensive as compared to the wrapper method [24].

## **2.3 Classification Algorithms**

In this study, three classifiers were used to study the effect of the FS on the prediction process and to compare results and measure the improvement. The following subsections provide a brief description of each classifier.

### **2.3.1 Naive Bayes Classifier (NB)**

NB is a probabilistic classifier that based on Bayes' theorem [3]. It is assumed that there is a strong independence among all the features and they are equally significant [17] [2]. The main advantage of the NB classifier is its short computational time for training [17].

### **2.3.2 K-Nearest Neighbor Classifier (KNN)**

KNN is a classification method that is part of a wider family of pattern recognition algorithms known as lazy learning or instance-based algorithms [3]. They are based on determining the similarities between the unlabeled new query instance and its nearest  $k$  neighbors from the labeled training instance stored in memory rather than performing the generalization in an explicit training phase. The fundamental principle behind  $k$ -NN is that close points in space are likely to have similar class concepts. The input to the  $k$ -NN in classification problems is the  $k$  closest examples among the training examples, and the output is the labels of these instances. For a given example, labeling is determined by the majority of votes cast by the  $k$  nearest neighbors. The comparison and computation of the distance between two points are based on a predefined distance metric, such as the Euclidean distance [3].

### **2.3.3 Support Vector Machines (SVM)**

SVM is a supervised learning method used to analyze data for classification and regression analysis [25]. It was proposed by Vapnik in 1995 [25]. The main idea of SVM is to divide the available data set into two groups by a hyperplane [2] in order to maximize the distance between the two groups [3]. SVM is a binary classifier that uses a linear method in addition to non-linear classification [3].

## **2.4 Overview of Particle Swarm Optimization (PSO)**

PSO is a meta-heuristic technique introduced by Kennedy and Eberhart [26] that was inspired by social behaviors seen in birds flocking and fish schooling. PSO is used to solve many continuous problems [11]. A swarm in PSO is made of multiple individuals known as particles who communicate through iterations to identify optimal solutions while traversing around the search space. PSO performs searches using a population (swarm) of individuals (particles) that are updated from iteration to iteration. The population size is denoted as  $p_{size}$ . The solution is represented as particle position. To find the optimal solution, each particle modifies its search direction based on two factors: its own best prior experience. The solution is represented as particle position ( $p_{best}$ ) and the best experience of all other particles solutions ( $g_{best}$ ).

### **2.4.1 Binary Particle Swarm Optimization for Feature Selection**

To use PSO as feature selection, the position of each particle is represented as a vector where its length is the number of features. Then search for an optimal solution by varying the vector entries values between 0 and 1. Zero means that the feature corresponding to this entry is not selected and one means this feature is selected. Therefore, each particle search for an optimal

solution based on the effectiveness of the current solution, and Pbest, and the best solution from other particles, Gbest. The effectiveness of the solution is measured using the fitness function. The fitness function trains the model on the selected features and evaluates it based on the training.

Many optimization problems in a space are discrete, Binary particle swarm optimization (BPSO) has been proposed to solve these types of tasks [12]. Its another version of PSO that utilizes the personal best (pbest) and global best (gbest) solutions to update the velocity and position[27]. The volicity compute how much the particle will move as following [27] [28] :

$$v_i^d(t+1) = wv_i^d(t) + c_1r_1(pbsest_i^d(t) - x_i^d(t)) + c_2r_2(gbest^d(t) - x_i^d(t)) \quad (1)$$

where  $v$  is the velocity,  $w$  is the inertia weight,  $c_1$  and  $c_2$  are the acceleration factors,  $r_1$  and  $r_2$  are two independent random numbers between 0 and 1,  $x$  is the position of particle (solution),  $pbsest$  is the personal best solution,  $gbsest$  is the global best solution for the population,  $i$  is the order of particle in the population,  $d$  is the dimension of search space, and  $t$  is the number of iterations. All the random numbers will be discussed in [section 5.2](#).

In BPSO, probabilities are used to determine the state of one bit, in other word, a particle moves in a state space constrained to zero and one on each dimension, for example if  $v_i^d = 0.20$ , then  $x_i^d$  will be near to zero more than one [12]. After the velocity is calculated using Equation (1), it will converted into probability value using Equation (2), is known as a transfer function [29].

$$S(v_i^d(t+1)) = \frac{1}{1 + \exp(-v_i^d(t+1))} \quad (2)$$

The position of particle is updated as shown in Equation (3):

$$x_i^d(t+1) = \begin{cases} 1, & \text{if } rand < S(v_i^d(t+1)) \\ 0, & \text{otherwise} \end{cases} \quad (3)$$

where  $rand$  is a random number between 0 and 1. Considering the minimization function that applied in this paper pbest and gbest is iteratively updated as follows:

$$pbest_i(t+1) = \begin{cases} x_i(t+1), & \text{if } F(x_i(t+1)) < F(pbest_i(t)) \\ pbest_i(t), & \text{otherwise.} \end{cases} \quad (4)$$

$$gbest(t+1) = \begin{cases} pbest_i(t+1), & \text{if } F(pbest_i(t+1)) < F(gbest(t)) \\ gbest(t), & \text{otherwise.} \end{cases} \quad (5)$$

where  $x$  is the solution,  $F(\cdot)$  is the fitness function, and  $t$  is the number of iterations.

### 3 Related work

Several research papers in the literature investigate the SDP problem. However, the most recent studies used machine learning approaches to create an appropriate model for this complex challenge. Some studies used pure machine learning methods with no pre-processing on the input datasets [30]. In contrast, others used a combination of pre-processing methods on the datasets, such as FS to lower the dimensionality of input datasets or noise reduction from unbalanced datasets. This section will review the works that used the PSO for features selection to improve SDP.

Wahono and Suryana [31] presented a PSO-bagging approach combination to improve the performance of SDP. PSO was employed to deal with feature selection, while the bagging approach was utilized to deal with class imbalance. In order to evaluate the suggested strategy, many machine learning classifiers were applied to nine datasets from NASA's metric data repository. The AUC results showed that the proposed technique enhanced the prediction performance of the most commonly used ML classifiers. Wahono and Ahmad published similar work in [32], in which GA and PSO algorithms were used as FS strategies for the SFP problem, while the bagging methodology was used to deal with the class imbalance problem. To test various FS techniques, ten classifiers were used across nine NASA MDP datasets. The AUC results revealed that the proposed FS techniques resulted in a major improvement in prediction performance for the majority of the used classifiers. Furthermore, it has been determined that there is no substantial difference between PSO and GA in FS for the majority of classifiers.

Arora and Saha [1] introduced SDP model based on two classifiers, extreme learning machine (ELM) and kernel-based ELM (KELM). They employed five wrapper-based including PSO and seven filter-based FS approaches in their approach. They chose seven datasets from the PROMISE repository to test their method. Furthermore, they employed the accuracy metric to assess the performance FS model. They discovered that ELM-based classifiers worked better with wrapper-based FS approaches, but KELM classifiers performed better with filter-based methods.

Recently, Malhorta et al. [33] used the Synthetic Minority Oversampling Technique (SMOTE) along with FS using PSO on object-oriented metrics. First, the SMOTE were used to tackle the issue of imbalanced data, while the PSO was applied to extract the optimal feature set. Then, the chosen features were utilized for training the SVM to predict defects. The result showed that the oversampling technique of SMOTE when combined with PSO for feature selection, can be used for building efficient SDP models.

As shown by past literature, several research publications examine the SDP problem. However, in reality, each project has its characteristics. Thus, it is critical to design a strong model that evaluates the acquired data early in the process. This encourages us to improve the PSO algorithm to use it as a FS algorithm as the initial step toward achieving a high-quality classifier.

## 4 Methodology

This section presents the explanation of the proposed method. The overall system architecture is presented in figure 1. The main stages are FS then classification. The features selection was used to enhance the model classification by selecting the most important features and removing the noise features. The following subsections explain the system stages.



**Figure 1** The System Architecture

### 4.1 Dataset Specification

We experimented the proposed method on different benchmarked datasets extracted from the PROMISE repository and NASA repository. The datasets were collected from real and open-source software projects. Eleven of these datasets are downloaded from the NASA corpus<sup>1</sup> (cleaned versions by [34]), while the remaining datasets are from

<sup>1</sup> [https://figshare.com/articles/dataset/MDP\\_data\\_sets\\_D\\_and\\_D\\_-\\_zipped\\_up/6071675](https://figshare.com/articles/dataset/MDP_data_sets_D_and_D_-_zipped_up/6071675)

the PROMISE software engineering corpus<sup>2</sup>. These projects have different specifications, such as the programming language, the code size, and software measures, detailed information on the datasets is listed in Table 1. PROMISE dataset has 20 static attributes and one dependent variable for each software project. On the other hand, NASA datasets have different number of attributes for each software project. The datasets consist of a set of features that have values and a goal field that describes the instance as defect or non-defect. These features describe the program from different sides including the lines of code measure (program length, count of lines of comments, count of lines of comments), McCabe metrics, base Halstead measures, derived Halstead measures, unique operators, unique operands, total operators, total operands, cyclomatic complexity, essential complexity, design complexity, and a branch-count. We choose PROMISE and NASA because these datasets are commonly used in SDP field. Note that, the datasets used in this study represent the dependent variable by one of two forms: binary form or numric form. In addition, all dataset features are uniformed by deleting the additional columns in dataset other versions files. The approach for applying training and testing in the experiments is based on a hold-out strategy in which each dataset is shuffled and divided into 70% for training and 30% for testing.

**Table 1: Datasets description.**

	Project	Language	Features	Instances	Defects	Non- Defects	Defect ratio
PROMISE	ant-1.7	Java	21	745	166	579	22.28
	camel-1.4	Java	21	872	145	727	16.63
	camel-1.6	Java	21	965	188	777	19.48
	ivy-2.0	Java	21	352	40	312	11.63
	jedit-4.2	Java	21	367	48	319	13.08
	jedit-4.3	Java	21	492	11	481	2.24
	poi-2.0	Java	21	314	37	277	11.78
	prop-6	Java	21	660	66	594	10.00
	xalan-2.5	Java	21	803	387	416	48.19
	xerces-1.2	Java	21	440	71	369	16.14
NASA	cm1	C	38	327	42	285	12.8
	jm1	C	22	7782	1672	6110	21.5
	kc1	C++	22	1183	314	869	26.5
	kc3	Java	40	194	36	158	18.6
	mc1	C & C++	39	1988	46	1942	2.3
	mw1	C	38	253	27	226	10.7
	pc1	C	38	705	61	644	8.7
	pc2	C	37	745	16	729	2.1
	pc3	C	38	1077	134	943	12.4
	pc4	C	38	1287	177	1110	13.8
	pc5	C++	39	1711	471	1240	27.5

## 4.2 Feature selection based on Sticky Binary Swarm Optimization

For feature selection, we used the improved BPSO proposed by Nguyen et al. [29] which is Sticky Binary Particle Swarm Optimization (SBPSO). SBPSO works as the flowchart presented in figure 2. The algorithm used the previous position to update the current particle position by flipping the entry  $d$  value to zero or one as follows.

$$x_d^{t+1} = \begin{cases} 1 - x_d^t, & \text{if } rand() < p_d \\ x_d^t, & \text{otherwise.} \end{cases} \quad (6)$$

<sup>2</sup> <http://promise.site.uottawa.ca/SERepository/>.

Where  $t$  represents the iteration number. The SBPSO uses flipping probability  $p$  instead of velocity. The flipping probability is expressed as follow:

$$p_d = i_s * (1 - stk_d) + i_p * |pb_d - x_d| + i_g * |gb_d - x_d| \quad (7)$$

$i_s$ ,  $i_p$ , and  $i_g$  are the weights of the sickness, personal best  $pb_d$ , and global best  $gb_d$  respectively. Where  $i_s + i_p + i_g = 1$ . The sickness value  $stk$  indicates how much the position entry will stick with its value.  $stk$  is set to 1 when the entry just flipped then decrease over a fixed number of steps  $ustkS$  until the entry flipped or become zero as follow:

$$stk_d^{t+1} = \begin{cases} 1, & \text{if the bit is just flipped} \\ \max\left(stk_d^t - \frac{1}{ustkS}, 0\right), & \text{otherwise} \end{cases} \quad (8)$$

They assume that ratio between  $i_p$  and  $i_g$  represented as  $\alpha$ ,  $\alpha = i_p / i_g$ . The values of  $i_p$  and  $i_g$  are expressed as follows:

$$i_p = \alpha \times \frac{1-i_s}{\alpha+1}, \quad i_g = \frac{1-i_s}{\alpha+1} \quad (9)$$

Therefore, the flipping probability could be rewrite as the follow:

$$p = \begin{cases} i_s \times (1 - stk_d) & \text{if } x_d = pb_d = gb_d \\ i_s \times \left(1 - stk_d - \frac{1}{\alpha+1}\right) + \frac{1}{\alpha+1} & \text{if } x_d = pb_d \neq gb_d \\ i_s \times \left(1 - stk_d - \frac{\alpha}{\alpha+1}\right) + \frac{\alpha}{\alpha+1} & \text{if } x_d = gb_d \neq pb_d \\ 1 - i_s * stk_d & \text{if } x_d \neq pb_d = gb_d \end{cases} \quad (10)$$

The following paragraphs illustrate each case:

- The first case:  $x_d = pb_d = gb_d$  the second and third terms of equation (7) will be zero.
- The second case:  $x_d = pb_d \neq gb_d$  the second term in (7) will be zero, and since  $gb_d$  and  $x_d$  are two different binary numbers the absolute value of their difference is one, hence the third term value is  $i_g$  then they substitute it by its value in equation (9).
- The third case:  $x_d = gb_d \neq pb_d$  the third term will be zero and the second term is  $i_p$ . Then they substitute it by its value in equation (9).
- Last case:  $x_d \neq pb_d = gb_d$ . The second term is  $i_p$  and the third term is  $i_g$ . knowing that  $i_p + i_g = (1 - i_s)$ , the result equation is presented in case 4.

Now, the Flipping probability depends on two parameters stickiness weight  $i_s$  and  $ustkS$  that control the sickness.  $\alpha$  is a fixed value that is set before starting the algorithm.  $i_s$  and  $ustkS$  are dynamically updated in each iteration as follow:

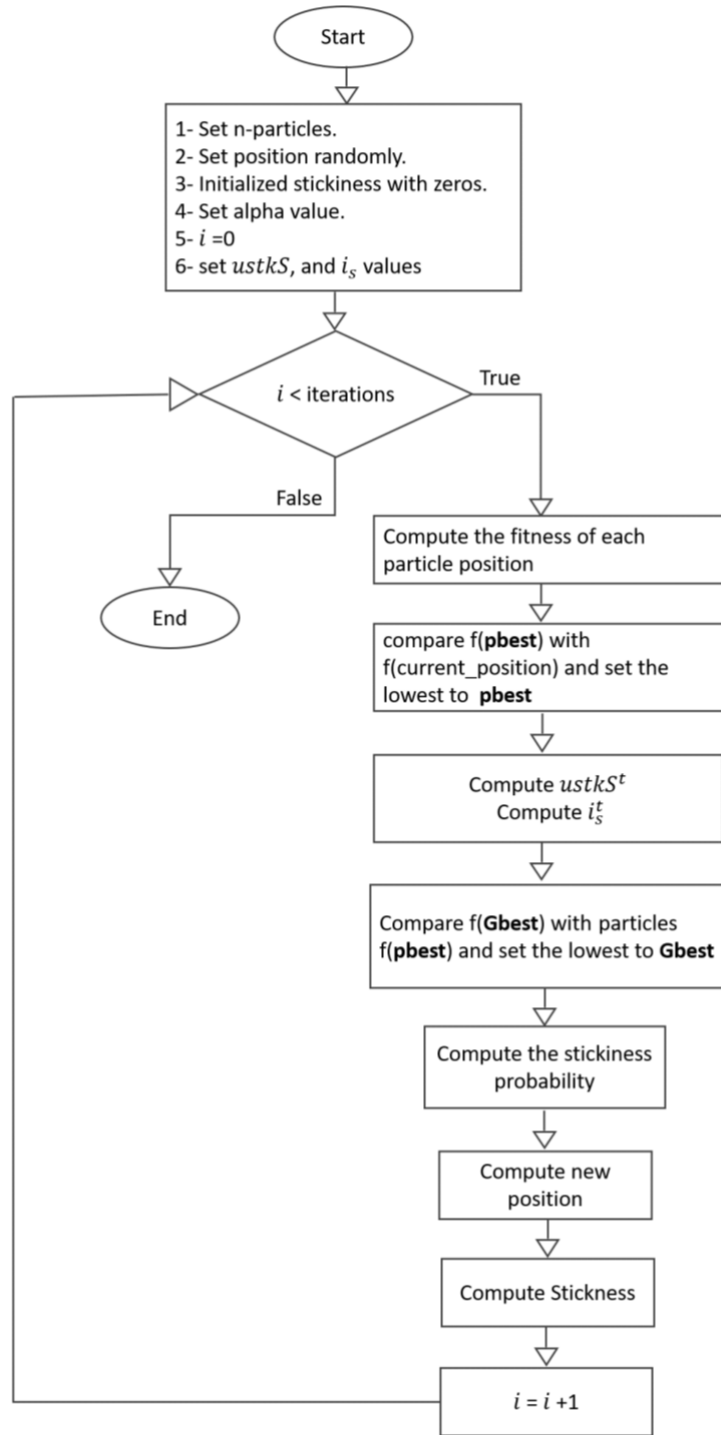
$$ustkS^t = ustkS^L + \frac{t}{T} * (ustkS^U - ustkS^L) \quad (11)$$

$$i_s^t = i_s^U - \frac{t}{T} * (i_s^U - i_s^L) \quad (12)$$

Where  $T$  is the total number of iterations,  $t$  is the current iteration  $U$  is upper bound,  $L$  is lower bound. The fitness function that assesses the position of the particle is the model error rate computed as the following:

$$Error_{rate} = \frac{flase\ prediction}{total\ number\ of\ sampe} \quad (13)$$

False prediction is the incorrect prediction on the testing dataset using the selected features that correspond to the particle's position. The total number of samples is the length of the testing dataset.



**Figure 2** SBPSO flowchart.



### 4.3 Classification

For classification, we train three machine learning models, SVM, KNN, and NB on the datasets. The three models were trained on the selected features from the previous stage. Also, we compare the models trained on the selected features resulted from SBPSO, BPSO, and without feature selection.

### 4.4 Evaluation

In the evaluation stage, the models were evaluated by predicting the defect using the testing dataset then we compare the prediction with the true label in the dataset. The assessment of each model is based on the evaluation metrics that will explained in [section 5.2](#).

## 5 Experimental Design

Both BPSO and SBPS have been implemented using the pyswarm<sup>3</sup> library using Python programming language. The following subsections explain the parameters setting and evaluations metrics used in this work.

### 5.1 Parameter setting

The BPSO parameters are  $w$ ,  $c_1$ ,  $c_2$ , numbers of particles, numbers of iterations. After testing ranges of values, the selected values are  $w = 0.4$ ,  $c_1 = 0.6$ ,  $c_2 = 0.3$ . Regarding SBPSO its parameters are  $\alpha$ , lower and upper bound of  $i_s$  and  $ustkS$ , Numbers of particles and numbers of iterations.  $\alpha$  set to 0.6, lower bound of  $i_s = 0$  and upper bound of  $i_s = \frac{10}{n}$  where  $n$  is the number of features. Lower bound of  $ustkS = 1 * \frac{T}{100}$  and upper bound of  $i_s = 1 * \frac{T}{100}$ , where  $T$  is the total number of iterations. The numbers of particles and numbers of iterations are the same for both BPSO and SBPSO 20, and 100 respectively. Regarding classifiers, we used RBF kernel for SVM, KNN with five neighbors, BN with default settings.

### 5.2 Model Evaluation Metrics

We employed a binary classification strategy to identify classes that are likely to have defects. A binary classifier can make two types of errors: false positives (FP) and false negatives (FN). A correctly categorized defected class is also a true positive (TP), whereas a correctly classified non-defected class is a true negative (TN). We examined classification outcomes using the following metrics: Accuracy, Precision, Recall, and F-measure, described as follows:

- **Accuracy:** address the number or percentage of correctly classified instances to the total sum of instances. It can be calculated by Equation (14):

$$Accuracy = \frac{TP + TN}{TP + FP + FN + TN} \quad (14)$$

- **Precision:** Addresses the percentage of successfully classified defective occurrences among the total number of retrieved instances. The best precision value is 1. The higher the precision is, the fewer false positives. It can be calculated by Equation (15):

$$Precision = \frac{TP}{TP + FP} \quad (15)$$

- **Recall:** Addresses The percentage of defective cases that were accurately classified. The best recall value is 1. The higher the recall is, the lower the number of false negatives. It can be calculated by Equation (16):

$$Recall = \frac{TP}{TP + FN} \quad (16)$$

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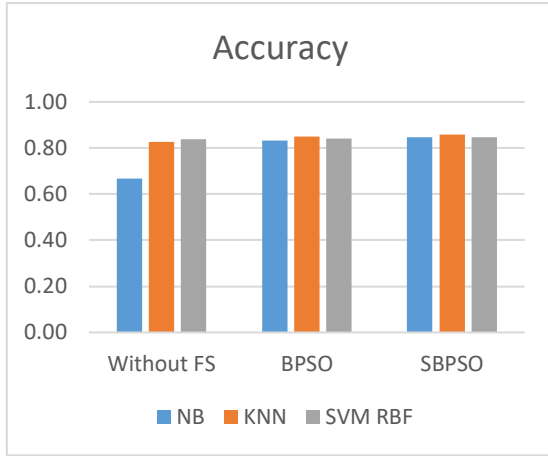
<sup>3</sup> <https://pyswarms.readthedocs.io/en/latest/#>

- **F-measure:** computes accuracy by taking Precision and Recall into account, which may be understood as a weighted average of Precision and Recall. The F-measure value varies between 0 and 1, with values closer to 1 indicating better classification results. It can be calculated by Equation (17):

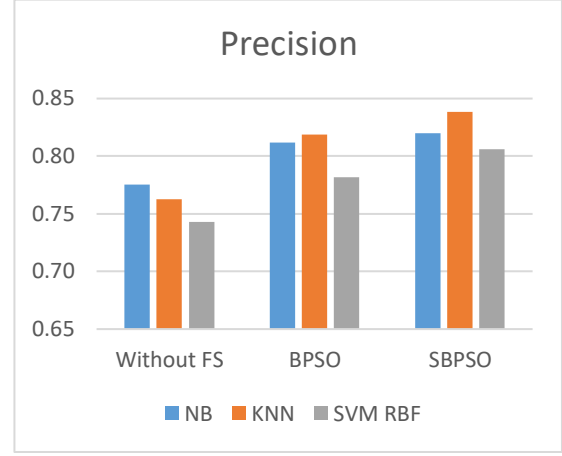
$$F - measure = 2 \frac{Recall * Precision}{Recall + Precision} \quad (17)$$

## 6 Results and Discussion

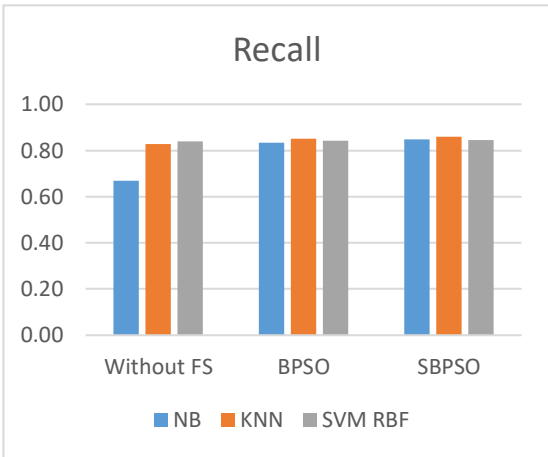
In this section, the three classifiers results are compared which are NB, KNN, and SVM, through three experiments for each classifier: without FS, with BPSO, and with the proposed SBPSO. Figures 3-9 show the visualization results of each metric. Also, Table 2 shows the numerical results of each experiment.



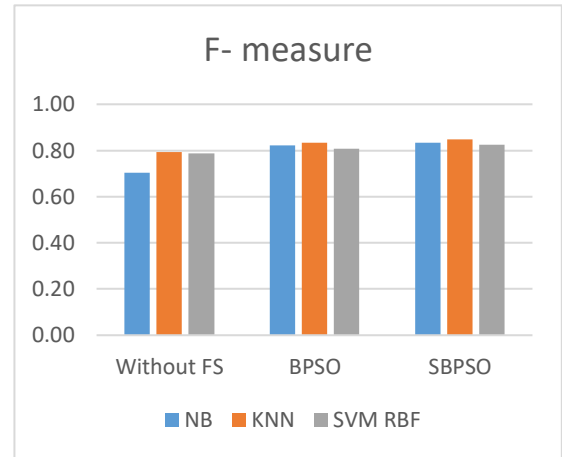
**Figure 3** Average accuracy of the three classifiers



**Figure 4** Average precision of the three classifiers



**Figure 5** Average recall of the three classifiers



**Figure 6** Average F-measure of the three classifiers

### 6.1 SBPSO effectivity

As can be seen, figure 3 shows the average accuracy obtained from testing the classifiers NB, KNN, and SVM. We observe that using FS with classification improves the accuracy. The lowest accuracies from the three classifiers were obtained when the classifiers were trained and tested on the datasets without FS. There was an increase in the accuracy values of the three classifiers when using BPSO as FS. The best accuracy results were obtained when using the SBPSO in the FS stage. This can be explained by the using FS stage

that has an effective influence on the classifiers' performance and the balancing between the exploration and exploitation that enhanced after using SBPSO. Moreover, figure 4, clearly shows that precision was improved after using SBPSO. Using SBPSO also slightly improved the Recall and F-measure as shown in Figures 5 and 6 respectively. As shown by table 2, the results of the NASA datasets are better than the results of PROMISE datasets we think this is due to the larger number of features that describe the software more efficiently to predict the defect.

## 6.2 Exploration and Exploitation of SBPSO and BPSO

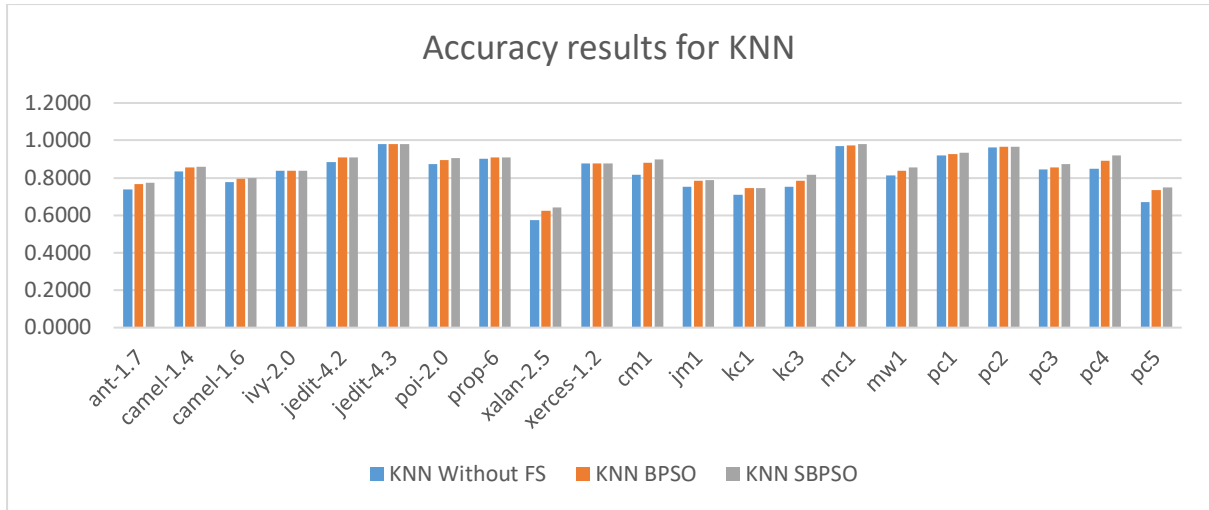
Exploration and exploitation are important factors for searching for optimal solutions. Exploration is searching in the whole search space to visit all locations, while exploitation is searching between visited locations [35]. Updating the positions in SBPSO depend on the previous position and the probability of flipping (as equation (6) shows). If the probability is high, the entry will flip. The flipping probability depends on the stickiness value of the entry, if the stickiness is high the flipping probability is low (as equation (7) show). The stickiness strategy balances between exploration and exploitation. The entry stick in the current value and other entries will search around for a fixed number of steps *ustkS* (exploitation) then the entry will flip (exploration). The results from table. 2 show that SBPSO outperforms BPSO. This is due to the optimal features' subset that SBPSO selects from its *gbest*. BPSO changes the position entry based on the velocity that computes how far the particle will go depending on *gbest* and *pbest* location (3).

## 6.3 Difference between classifiers

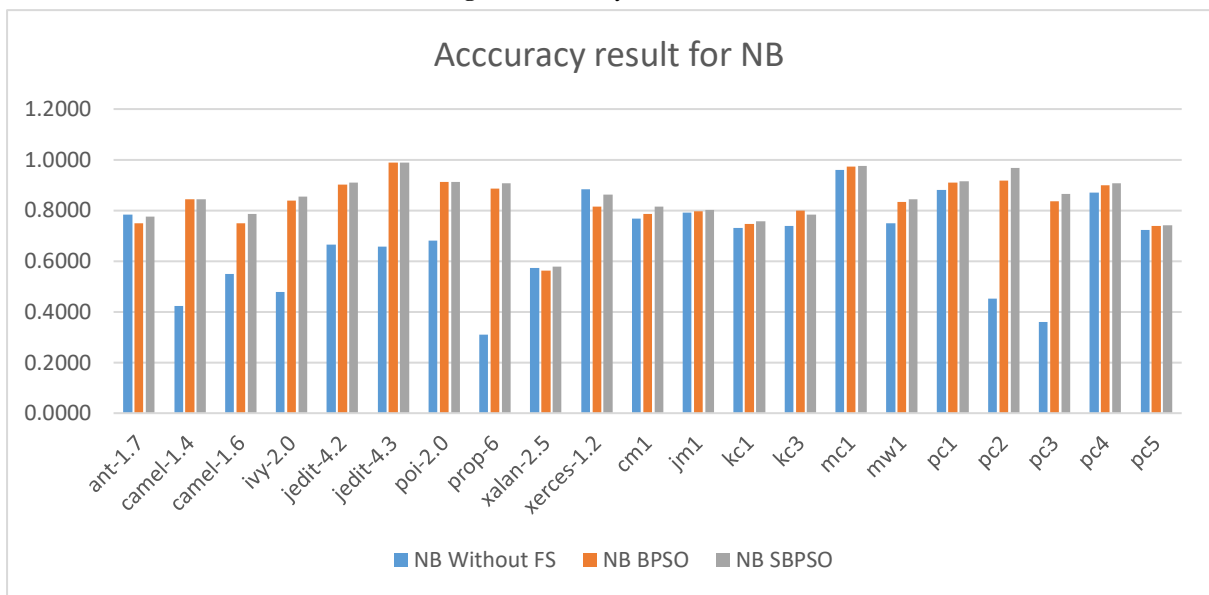
Figure 3 shows that the SVM classifier was the best in the experiment that was done without FS, while in the BPSO and SBPSO experiments, KNN outperformed the rest of the classifiers followed by the SVM. A detailed representation of the KNN results are shown in figure 7. As we observe from figures 7-9, the classifier which is the most influential by features selection is NB we think that due to its mechanism where it gives each feature a Bayesian probability. The probability is affected by the number of features. Therefore, by removing unnecessary features, the probability will be more accurate and the influential features on the classification will have a higher probability.

**Table 2:** Average results of the three classifiers NB, KNN, and SVM RBF

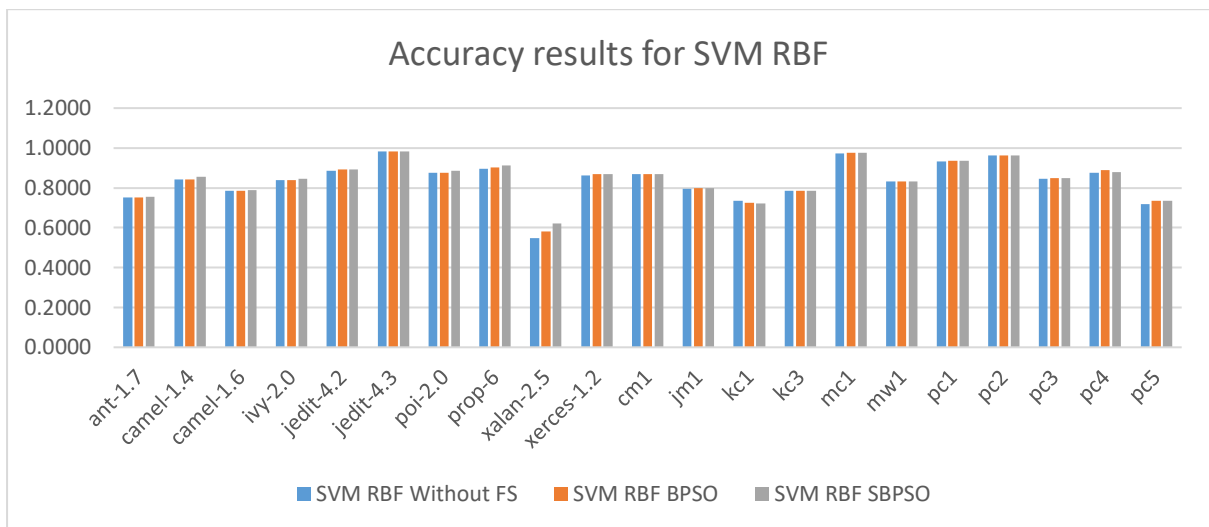
		NB			KNN			SVM RBF		
		Without FS	BPSO	SBPSO	Without FS	BPSO	SBPSO	Without FS	BPSO	SBPSO
PROMISE	Accuracy	0.60	0.82	0.84	0.83	<b>0.85</b>	<b>0.85</b>	0.83	0.83	0.84
	Precision	0.74	0.79	0.80	0.76	0.79	<b>0.81</b>	0.71	0.73	0.78
	Recall	0.60	0.82	0.84	0.83	<b>0.85</b>	<b>0.85</b>	0.83	0.83	0.84
	F-measure	0.65	0.81	0.82	0.79	0.82	<b>0.83</b>	0.77	0.78	0.81
NASA	Accuracy	0.73	0.84	0.85	0.82	0.85	<b>0.87</b>	0.85	0.85	0.85
	Precision	0.80	0.83	0.84	0.77	0.84	<b>0.87</b>	0.77	0.83	0.83
	Recall	0.75	0.83	0.85	0.80	0.85	<b>0.87</b>	0.81	0.84	0.84
	F-measure	0.67	0.80	0.81	0.78	0.81	<b>0.82</b>	0.76	0.77	0.80



**Figure 7** Accuracy results for KNN



**Figure 8** Accuracy results for NB



**Figure 9** Accuracy results for SVM RBF

## 6.4 Analytical Description of the Selected Features

As [3] do in this section, we present the selected features by SBPSO for each dataset. Table 3 present the selected features from each dataset, the number of All features (AF), Selected Features (SF) and Features Reduction Ratio (FRR). The FRR is computed as the following:

$$FRR = \frac{AF - SF}{Af} \quad (18)$$

We compare the influence of features for the PROMISE dataset since the features for each dataset are the same. The most selected features in PROMISE are F10 and F12. They selected 8 times in 10 datasets with a selection ratio of 0.8. Table 4 present the feature number, number of selected times, selection ratio, and the feature.

**Table 3:** Selected features in software datasets.

Project	AF	SF	FRR%	Selected Features
ant-1.7	21	10	52	F2, F3, F4, F5, F8, F9, F12, F14, F15, F20
camel-1.4	21	8	62	F3, F5, F8, F10, F12, F13, F16, F19
camel-1.6	21	9	57	F1, F4, F7, F8, F12, F14, F15, F18, F20
ivy-2.0	21	8	62	F1, F3, F4, F7, F9, F10, F14, F17
jedit-4.2	21	12	43	F1, F3, F4, F5, F8, F9, F10, F13, F14, F17, F18, F20
jedit-4.3	21	10	52	F7, F8, F10, F12, F13, F15, F17, F18, F19, F20
poi-2.0	21	8	62	F2, F10, F12, F15, F16, F18, F19, F20
prop-6	21	11	48	F3, F4, F5, F6, F8, F10, F12, F14, F16, F17, F19
xalan-2.5	21	10	52	F1, F8, F10, F12, F14, F15, F18, F20
xerces-1.2	21	9	57	F1, F3, F4, F6, F9, F10, F11, F12, F16
cm1	38	14	63	F1, F4, F6, F7, F9, F14, F15, F22, F23, F26, F31, F32, F3, F35
jm1	22	12	45	F2, F3, F4, F8, F9, F10, F13, F16, F17, F18, F19, F20
kc1	22	7	68	F2, F4, F5, F14, F17, F18, F20
kc3	40	19	53	F3, F6, F7, F9, F10, F11, F12, F15, F18, F19, F24, F25, F28, F31, F33, F34, F35, F37, F38
mc1	39	17	56	F1, F2, F3, F4, F5, F6, F9, F10, F12, F14, F17, F20, F22, F24, F29, F30, F37
mw1	38	17	55	F1, F5, F6, F7, F8, F11, F12, F14, F16, F17, F21, F25, F26, F29, F31, F32, F35
pc1	38	14	63	F2, F3, F4, F7, F9, F10, F12, F17, F19, F28, F29, F31, F32, F36
pc2	37	15	59	F3, F4, F5, F6, F9, F12, F15, F16, F20, F21, F24, F25, F29, F30, F31
pc3	38	17	55	F1, F2, F3, F7, F11, F15, F18, F22, F23, F24, F26, F28, F29, F32, F34, F35, F36
pc4	38	10	74	F3, F9, F10, F12, F15, F22, F24, F26, F30, F32
pc5	39	13	67	F1, F2, F3, F4, F15, F17, F18, F27, F31, F33, F34, F36, F37

**Table 4: PROMISE dataset features selection**

<b>F no.</b>	<b>Feature description</b>	<b>Selected times</b>	<b>selection ratio</b>
F1	Weighted methods per class	5	0.25
F2	Depth of inheritance tree	2	0.1
F3	Number of children	5	0.25
F4	Coupling between objects	6	0.3
F5	Response for a class	4	0.2
F6	Lack of cohesion in methods	2	0.1
F7	Another lcom metric proposed by Henderson-Sellers	3	0.15
F8	Number of public methods	7	0.35
F9	Number of lines of code	4	0.2
<b>F10</b>	Fraction of private or protected attributes	<b>8</b>	<b>0.4</b>
F11	Number of fields that are user-defined types	1	0.05
<b>F12</b>	Fraction of accessible methods that are inherited	<b>8</b>	<b>0.4</b>
F13	Cohesion among methods of a class based on parameter list	3	0.15
F14	Inheritance coupling	6	0.3
F15	Coupling between methods	5	0.25
F16	Average method complexity	3	0.15
F17	Number of classes depending on a class	4	0.2
F18	Number of classes a class depends on	5	0.25
F19	Maximum McCabe's cyclomatic complexity score of methods	3	0.15
F20	Mean of McCabe's cyclomatic complexity score of methods	5	0.25

## 7 Conclusions

This paper propose an SDP system using SBPSO that enhanced the FS to select the most important features and increase the accuracy of the classification. We compared the SDP performance using three expermint; SBPSO as FS, BPSO as FS, and without FS. Also, we conducted experiments on three classifiers, KNN, SVM, NB. The datasets used in the expermint were Promice and Nasa. This papers shows that SDP using SBPSO outperform BPSO and SDP without FS. Moreover, we discuss the effectiveness of SBPSO and compare it with BSPO in terms of exploration and exploitation. SBPSO balances between exploration and exploitation using the stickiness strategy. The expermint shows that the NB classifier is the most affected classifier by feature selection. In addition, we presented an nalytical description of the selected features. Finally, these results shows that the proposed system can serve as an effective predictive model for the software defect problem.

For future works, we suggest applying the proposed model using diffrent fitness function to obtain better results. In addition to enhance the prediction process by applying deep learning models.

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